## Applicant(s)/Patent Under Reexamination 10/039,385 YOHE ET AL. Notice of References Cited Art Unit Examiner 2155

Liang-che Alex Wang

Application/Control No.

Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,675,802	10-1997	Allen et al.	717/103
	В	US-5,832,514	11-1998	Norin et al.	707/202
	С	US-6,148,005	11-2000	Paul et al.	370/469
	D	US-6,567,929	05-2003	Bhagavath et al.	714/18
	Е	US-6,834,326	12-2004	Wang et al.	711/114 .
	F	US-2002/0065929	05-2002	Kamentsky et al.	709/231
	G	US-2002/0114283	08-2002	Lee , Jack Yiu-Bun	370/252
	Н	US-2002/0129159	09-2002	Luby et al.	709/236
	ı	US-2002/0184376	12-2002	Sternagle, Richard Henry	709/230
	J	US-2003/0126514	07-2003	Shabbir Alam et al.	714/43
	К	US-6,247,059	06-2001	Johnson et al.	709/237
	L	US-		,	
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р			•		
	Q					
	R	B .				
	S					
	Т					·

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
	U		
	V		
	w		•
	×		

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.